

Search Notes**Application/Control No.**

10/635,818

**Applicant(s)/Patent under
Reexamination**

HARRINGTON ET AL.

Examiner

Shin-Lin Chen

Art Unit

1632

SEARCHED

Class	Subclass	Date	Examiner
424	93.21		
435	320.1		
	455		
536	23.1		
	23.5		
	24.1	4/3/2009	SLC

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
424	93.21	4/3/2009	SLC
435	320.1	4/3/2009	SLC
	455	4/3/2009	SLC
536/23.1, 23.5, 24.1, AU interference search.		4/3/2009	SLC

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Updated, inventor name search.	4/3/2009	SLC